

2N7002CK

60 V, 0.3 A N-channel Trench MOSFET

Rev. 01 — 11 September 2009

Product data sheet

1. Product profile

1.1 General description

ESD protected N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features

- Logic-level compatible
- Very fast switching
- Trench MOSFET technology
- ESD protection up to 3 kV

1.3 Applications

- Relay driver
- High-speed line driver
- Low-side loadswitch
- Switching circuits

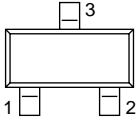
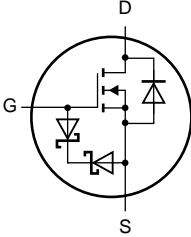
1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage		-	-	60	V
I_D	drain current		-	-	300	mA
I_{DM}	peak drain current	single pulse; $t_p \leq 10 \mu s$	-	-	1.2	A
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 10 V$; $I_D = 500 mA$	-	1.1	1.6	Ω

2. Pinning information

Table 2. Pinning

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	S	source		
3	D	drain		

017aaa000

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
2N7002CK	TO-236AB	plastic surface-mounted package; 3 leads	SOT23

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
2N7002CK	LP*

- [1] * = -: made in Hong Kong
 * = p: made in Hong Kong
 * = t: made in Malaysia
 * = W: made in China

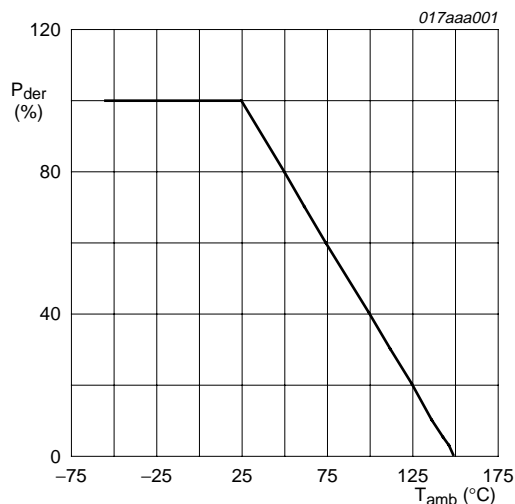
5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

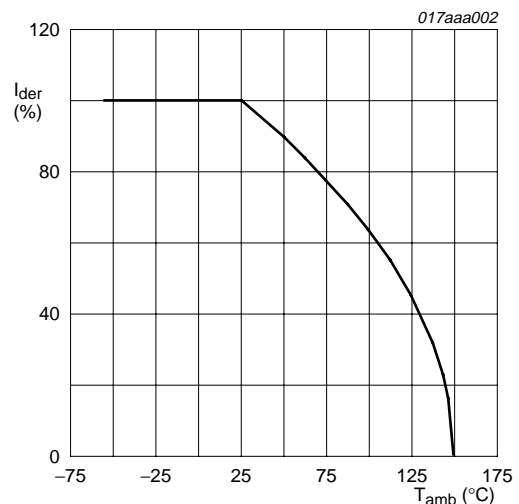
Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 150 °C	-	60	V
V _{GS}	gate-source voltage		-	±20	V
I _D	drain current	V _{GS} = 10 V			
		T _{amb} = 25 °C	-	300	mA
		T _{amb} = 100 °C	-	190	mA
I _{DM}	peak drain current	T _{amb} = 25 °C; t _p ≤ 10 μs	-	1.2	A
P _{tot}	total power dissipation	T _{amb} = 25 °C	[1]	350	mW
T _j	junction temperature			150	°C
T _{amb}	ambient temperature		-55	+150	°C
T _{stg}	storage temperature		-65	+150	°C
Source-drain diode					
I _S	source current	T _{amb} = 25 °C	-	200	mA
I _{SM}	peak source current	T _{amb} = 25 °C; t _p ≤ 10 μs	-	1.2	A
ElectroStatic Discharge (ESD)					
V _{ESD}	electrostatic discharge voltage	all pins; human body model; C = 100 pF; R = 1.5 kΩ	-	3	kV

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 1 cm².



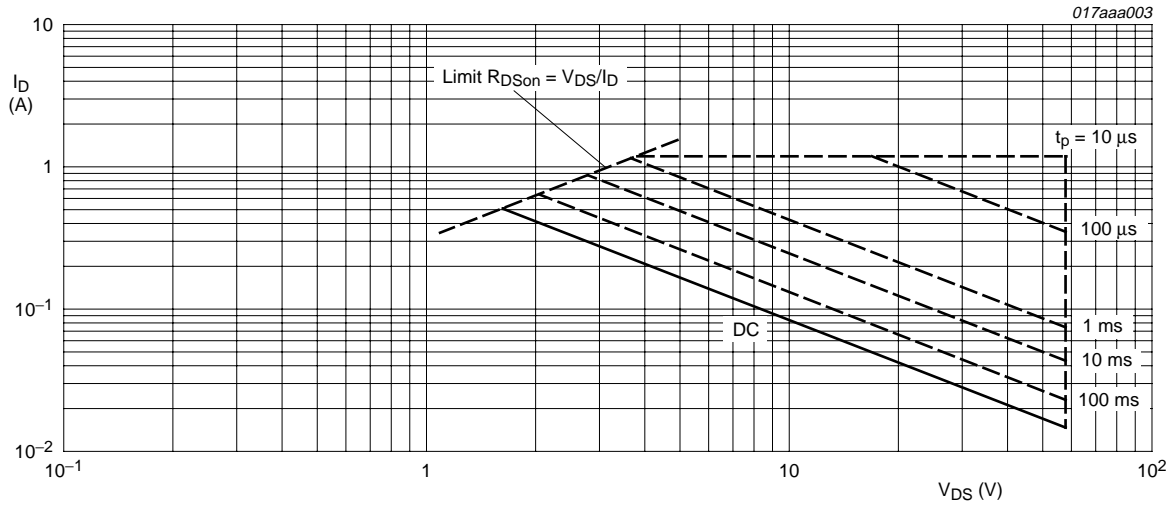
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 1. Normalized total power dissipation as a function of ambient temperature



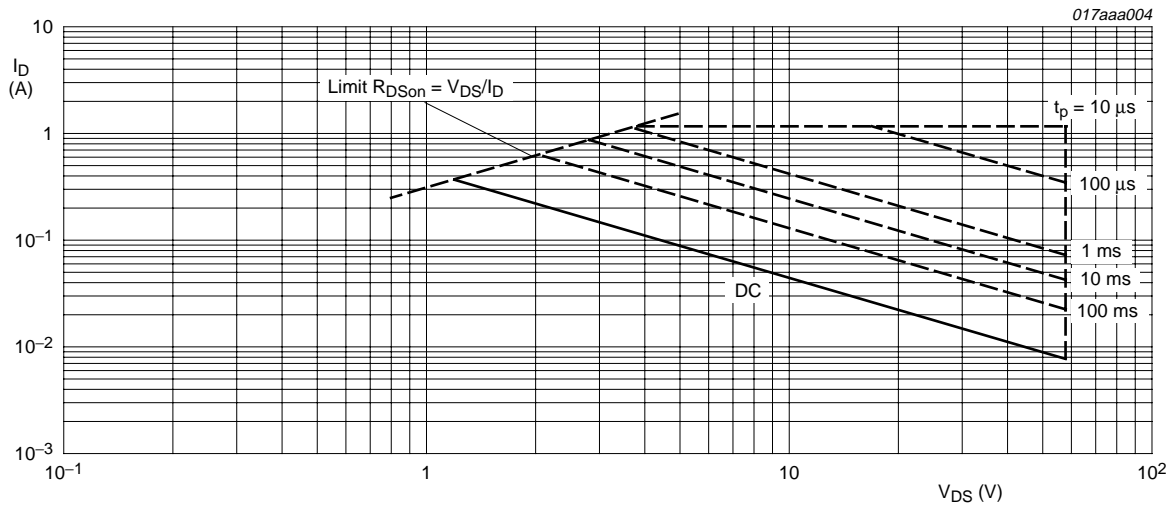
$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized continuous drain current as a function of ambient temperature



$T_{sp} = 25\text{ °C}$; $I_{DM} = \text{single pulse}$; $V_{GS} = 10\text{ V}$

Fig 3. Safe operating area; junction to solder point; continuous and peak drain currents as a function of drain-source voltage



$T_{amb} = 25\text{ °C}$; $I_{DM} = \text{single pulse}$; $V_{GS} = 10\text{ V}$

Fig 4. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1] -	350	500	K/W

Table 6. Thermal characteristics ...continued

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	150	K/W

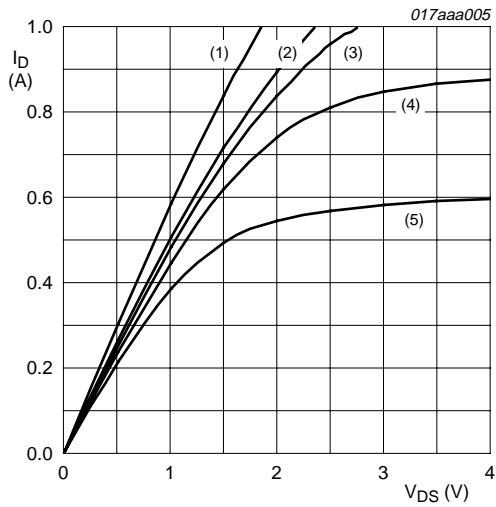
[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

7. Characteristics

Table 7. Characteristics

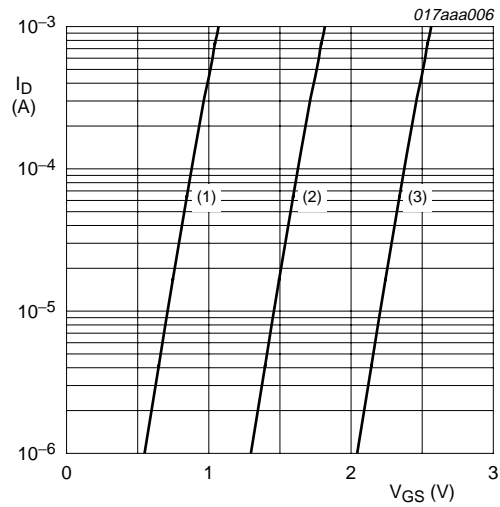
$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 10\text{ }\mu\text{A}; V_{GS} = 0\text{ V}$ $T_j = 25\text{ }^{\circ}\text{C}$	60	-	-	V
		$T_j = -55\text{ }^{\circ}\text{C}$	55	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 250\text{ }\mu\text{A}; V_{DS} = V_{GS};$ $T_j = 25\text{ }^{\circ}\text{C}$	1	1.75	2.5	V
I_{DSS}	drain leakage current	$V_{DS} = 60\text{ V}; V_{GS} = 0\text{ V}$ $T_j = 25\text{ }^{\circ}\text{C}$	-	-	100	nA
		$T_j = 150\text{ }^{\circ}\text{C}$	-	-	1	μA
I_{GSS}	gate leakage current	$V_{GS} = \pm 20\text{ V}; V_{DS} = 0\text{ V}$	-	-	5	μA
		$V_{GS} = \pm 10\text{ V}; V_{DS} = 0\text{ V}$	-	50	450	nA
		$V_{GS} = \pm 5\text{ V}; V_{DS} = 0\text{ V}$	-	-	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 4.5\text{ V};$ $I_D = 200\text{ mA}$ $T_j = 25\text{ }^{\circ}\text{C}$	-	1.3	3	Ω
		$T_j = 150\text{ }^{\circ}\text{C}$	-	2.8	4.4	Ω
		$V_{GS} = 10\text{ V}; I_D = 500\text{ mA}$	-	1.1	1.6	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 200\text{ mA};$ $V_{DS} = 10\text{ V};$ $V_{GS} = 4.5\text{ V}$	-	1.09	1.3	nC
Q_{GS}	gate-source charge		-	0.22	-	nC
Q_{GD}	gate-drain charge		-	0.23	-	nC
C_{iss}	input capacitance	$V_{GS} = 0\text{ V}; V_{DS} = 25\text{ V};$ $f = 1\text{ MHz}$	-	47.2	55	pF
C_{oss}	output capacitance		-	11	20	pF
C_{rss}	reverse transfer capacitance		-	5	7.5	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 15\text{ V};$ $R_L = 15\text{ }\Omega;$ $V_{GS} = 10\text{ V};$ $R_G = 6\text{ }\Omega$	-	8	15	ns
t_r	rise time		-	8	15	ns
$t_{d(off)}$	turn-off delay time		-	38	50	ns
t_f	fall time		-	22	35	ns
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 200\text{ mA}; V_{GS} = 0\text{ V}$	0.47	0.79	1.1	V



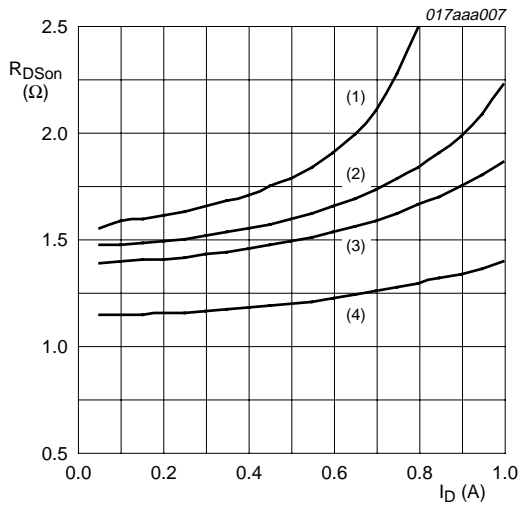
- $T_j = 25\text{ }^\circ\text{C}$
- (1) $V_{GS} = 10\text{ V}$
 - (2) $V_{GS} = 5\text{ V}$
 - (3) $V_{GS} = 4.5\text{ V}$
 - (4) $V_{GS} = 4\text{ V}$
 - (5) $V_{GS} = 3.5\text{ V}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



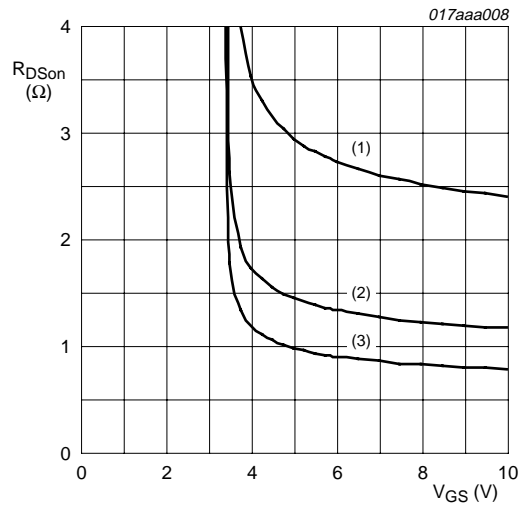
- $T_j = 25\text{ }^\circ\text{C}; V_{DS} = 5\text{ V}$
- (1) minimum values
 - (2) typical values
 - (3) maximum values

Fig 6. Sub-threshold drain current as a function of gate-source voltage



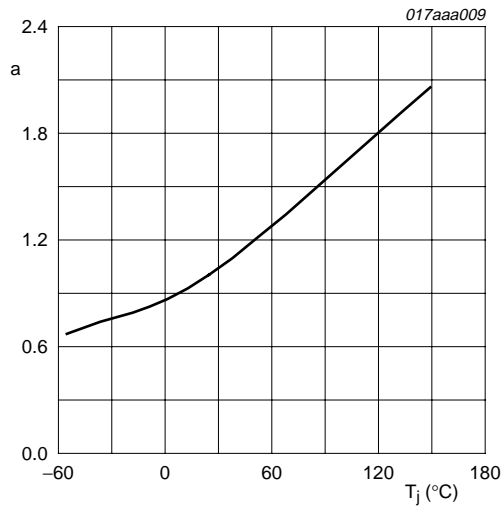
- $T_j = 25\text{ }^\circ\text{C}$
- (1) $V_{GS} = 4\text{ V}$
 - (2) $V_{GS} = 4.5\text{ V}$
 - (3) $V_{GS} = 5\text{ V}$
 - (4) $V_{GS} = 10\text{ V}$

Fig 7. Drain-source on-state resistance as a function of drain current; typical values



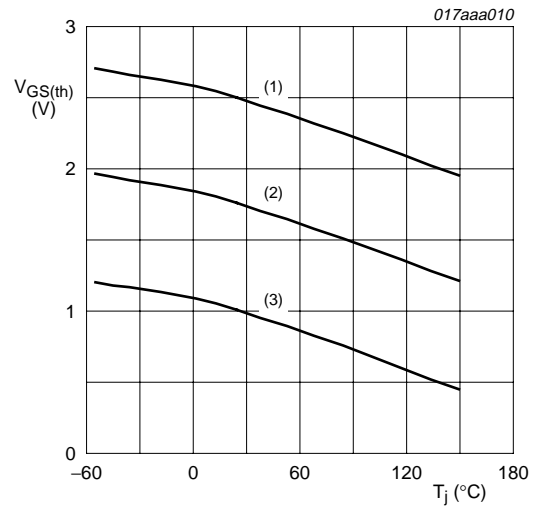
- $I_D = 500\text{ mA}$
- (1) $T_j = 150\text{ }^\circ\text{C}$
 - (2) $T_j = 25\text{ }^\circ\text{C}$
 - (3) $T_j = -55\text{ }^\circ\text{C}$

Fig 8. Drain-source on-resistance as a function of gate-source voltage; typical values



$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

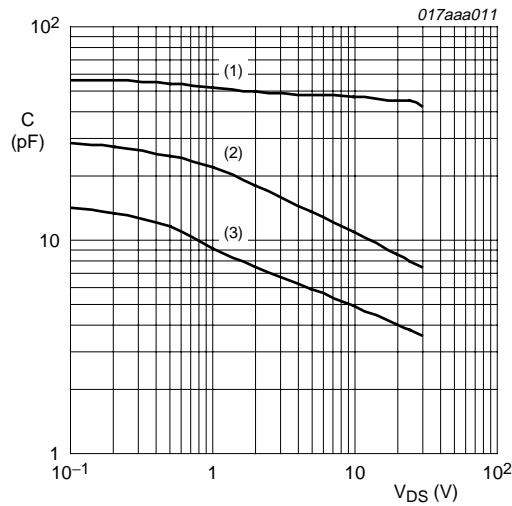
Fig 9. Normalized drain-source on-state resistance factor as a function of junction temperature



$I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$

- (1) maximum values
- (2) typical values
- (3) minimum values

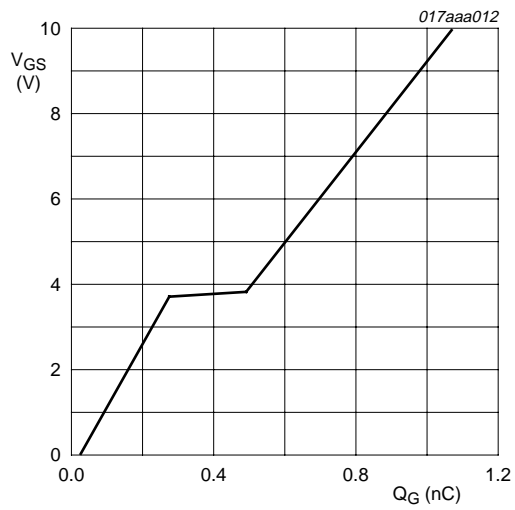
Fig 10. Gate-source threshold voltage as a function of junction temperature



$V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

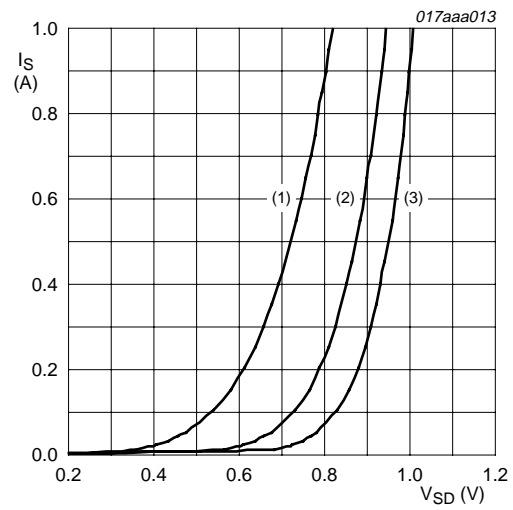
- (1) C_{iss}
- (2) C_{oss}
- (3) C_{rss}

Fig 11. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



$I_D = 200 \text{ mA}$; $V_{DD} = 30 \text{ V}$; $T_j = 25 \text{ }^\circ\text{C}$

Fig 12. Gate-source voltage as a function of gate charge; typical values



$V_{GS} = 0 \text{ V}$

- (1) $T_j = 150 \text{ }^\circ\text{C}$
- (2) $T_j = 25 \text{ }^\circ\text{C}$
- (3) $T_j = -55 \text{ }^\circ\text{C}$

Fig 13. Source current as a function of source-drain voltage; typical values

8. Package outline

Plastic surface-mounted package; 3 leads

SOT23

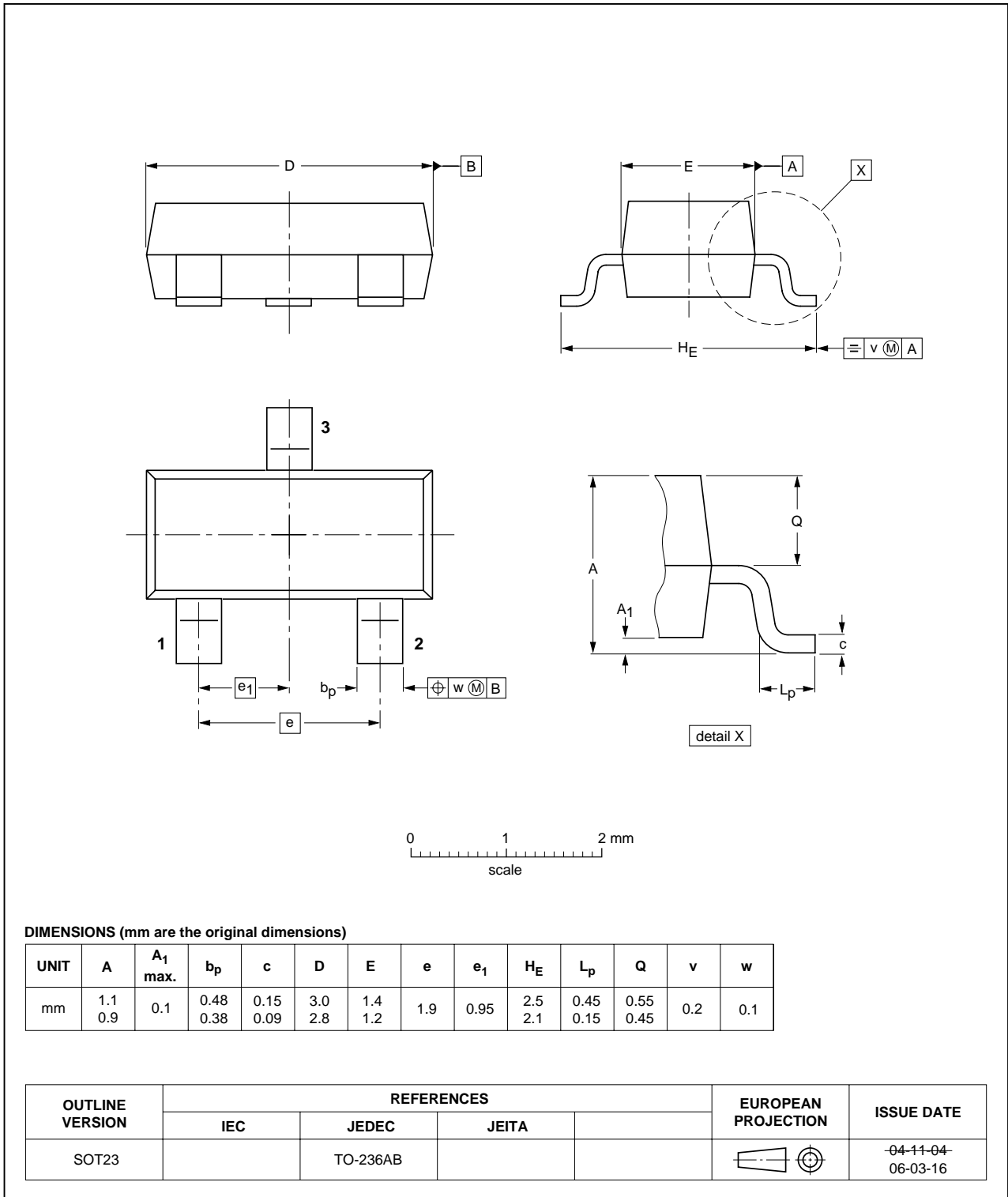


Fig 14. Package outline SOT23 (TO-236AB)

9. Soldering

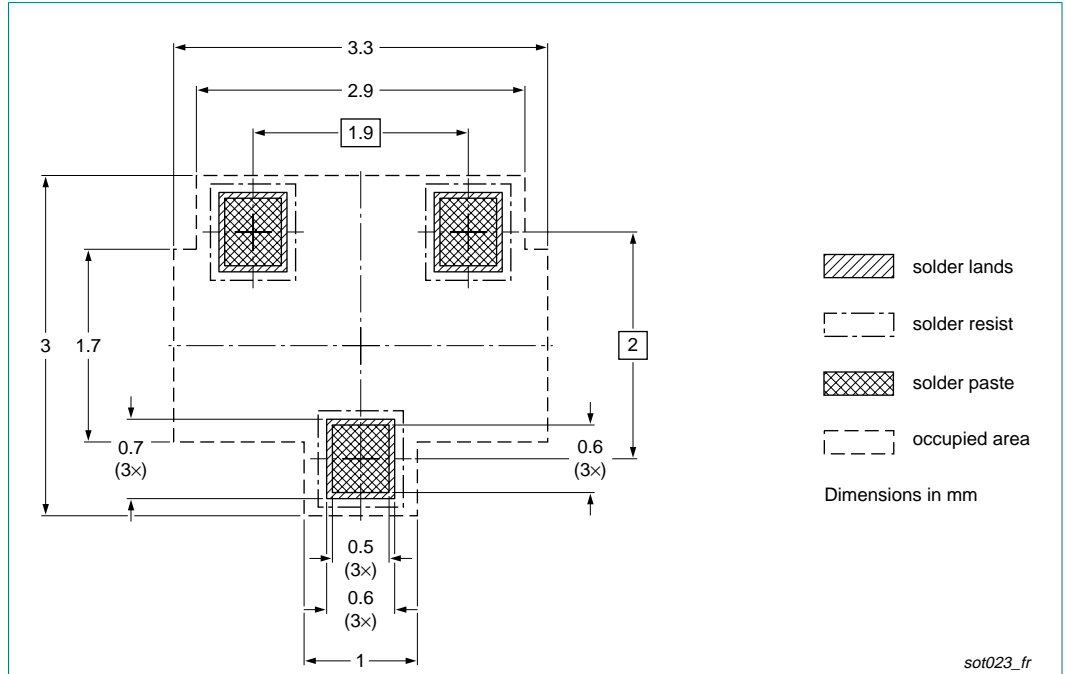


Fig 15. Reflow soldering footprint SOT23 (TO-236AB)

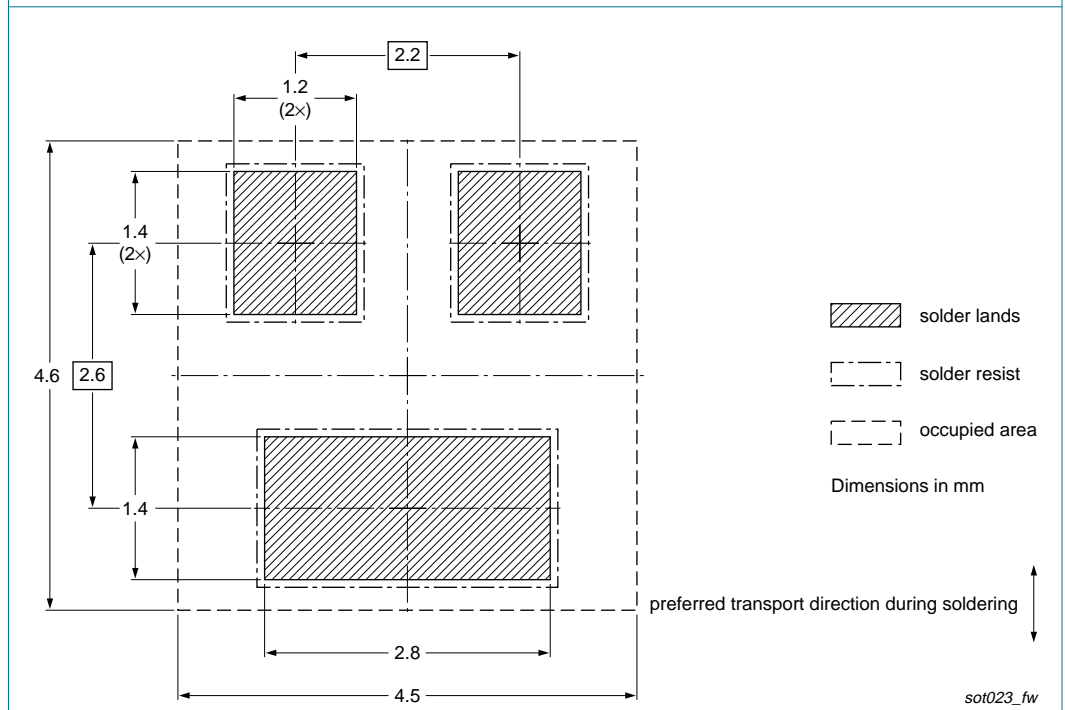


Fig 16. Wave soldering footprint SOT23 (TO-236AB)

10. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
2N7002CK_1	20090911	Product data sheet	-	-

11. Legal information

11.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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